Searcn Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
09/587,960	YUNG ET AL.
Examiner	Art Unit
DANH C. LE	2617

SEARCHED				
Class	Subclass	Date	Examiner	
455	430 429	8 14 06	DCL	
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370	316			
	310			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
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Inventor Name Search (Check for dauble patenting	81406	DCL
(Check for dauble patenting		•
EAST Search		
(US, USPUB, JPU, DERWEN	T	
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